

**Search Notes**

Application/Control No.

10/811,932

Examiner

Elias Desta

Applicant(s)/Patent under  
Reexamination

YUE ET AL.

Art Unit

2857

**SEARCHED**

Class	Subclass	Date	Examiner
702	109,127,1 82,189,19 0,193-194	5/17/2006	E.D
438	5,10,17	5/17/2006	E.D
219	490	5/17/2006	E.D
700	19,28,32	5/17/2006	E.D

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
702	127,182 189	5/17/2006	E.D
438	5,10,17	5/17/2006	E.D
700	19,28,32	5/17/2006	E.D
219/490		5/17/2006	E.D

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Method of search: EAST, YAHOO, GOOGLE, IEEE Explore, CRC and Semiconductor Publications	5/17/2006	E.D
Consulted: Patrick Assouad, cl. 702, au: 2857 (rest.), Nadine Norton, cl. 438, au: 1765; Anthony Knight, cl. 700, au. 2121.	11/22/2005	E.D
Text or key word searches: see attachment.	5/17/2006	E.D